

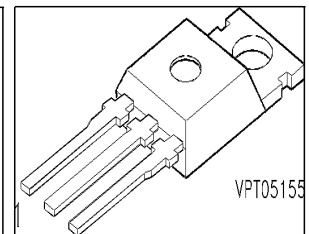
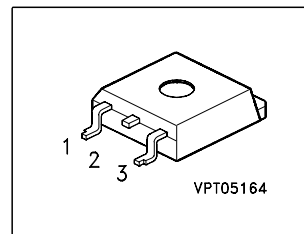
### SIPMOS® Power Transistor

#### Features

- N channel
- Enhancement mode
- Avalanche rated
- Logic Level
- dv/dt rated
- 175°C operating temperature

#### Product Summary

Drain source voltage	$V_{DS}$	30	V
Drain-Source on-state resistance	$R_{DS(on)}$	0.006	$\Omega$
Continuous drain current	$I_D$	80	A



Type	Package	Ordering Code	Packaging
SPP80N03L	P-TO220-3-1	Q67040-S4735-A2	Tube
SPB80N03L	P-TO263-3-2	Q67040-S4735-A3	Tape and Reel

Pin 1	Pin 2	Pin 3
G	D	S

#### Maximum Ratings, at $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current $T_C = 25\text{ °C}$ , <sup>1)</sup> $T_C = 100\text{ °C}$	$I_D$	80 80	A
Pulsed drain current $T_C = 25\text{ °C}$	$I_{Dpulse}$	320	
Avalanche energy, single pulse $I_D = 80\text{ A}$ , $V_{DD} = 25\text{ V}$ , $R_{GS} = 25\text{ }\Omega$	$E_{AS}$	700	mJ
Avalanche energy, periodic limited by $T_{jmax}$	$E_{AR}$	30	
Reverse diode dv/dt $I_S = 80\text{ A}$ , $V_{DS} = 24\text{ V}$ , $di/dt = 200\text{ A}/\mu\text{s}$ , $T_{jmax} = 175\text{ °C}$	dv/dt	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation $T_C = 25\text{ °C}$	$P_{tot}$	300	W
Operating and storage temperature	$T_j, T_{stg}$	-55... +175	$^{\circ}\text{C}$
IEC climatic category; DIN IEC 68-1		55/175/56	

### Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Characteristics</b>					
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.5	K/W
Thermal resistance, junction - ambient, leded	$R_{thJA}$	-	-	62	
SMD version, device on PCB: @ min. footprint @ 6 cm <sup>2</sup> cooling area <sup>2)</sup>	$R_{thJA}$	-	-	62 40	

### Electrical Characteristics, at $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Static Characteristics</b>					
Drain- source breakdown voltage $V_{GS} = 0\text{ V}$ , $I_D = 0.25\text{ mA}$	$V_{(BR)DSS}$	30	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 240\text{ }\mu\text{A}$	$V_{GS(th)}$	1.2	1.6	2	
Zero gate voltage drain current $V_{DS} = 30\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25\text{ °C}$ $V_{DS} = 30\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 150\text{ °C}$	$I_{DSS}$	-	0.1 -	1 100	$\mu\text{A}$
Gate-source leakage current $V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$	$I_{GSS}$	-	10	100	
Drain-Source on-state resistance $V_{GS} = 4.5\text{ V}$ , $I_D = 80\text{ A}$ $V_{GS} = 10\text{ V}$ , $I_D = 80\text{ A}$	$R_{DS(on)}$	-	0.0053 0.0033	0.008 0.006	$\Omega$

<sup>1</sup> current limited by bond wire

<sup>2</sup> Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at  $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Dynamic Characteristics</b>					
Transconductance $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ , $I_D = 80\text{ A}$	$g_{fs}$	30	125	-	S
Input capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{iss}$	-	4640	5900	pF
Output capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{oss}$	-	1915	2500	
Reverse transfer capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{rss}$	-	785	1000	
Turn-on delay time $V_{DD} = 15\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 80\text{ A}$ , $R_G = 1.25\text{ }\Omega$	$t_{d(on)}$	-	30	45	ns
Rise time $V_{DD} = 15\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 80\text{ A}$ , $R_G = 1.25\text{ }\Omega$	$t_r$	-	50	75	
Turn-off delay time $V_{DD} = 15\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 80\text{ A}$ , $R_G = 1.25\text{ }\Omega$	$t_{d(off)}$	-	40	60	
Fall time $V_{DD} = 15\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 80\text{ A}$ , $R_G = 1.25\text{ }\Omega$	$t_f$	-	50	75	

**Electrical Characteristics**, at  $T_j = 25\text{ °C}$ , unless otherwise specified

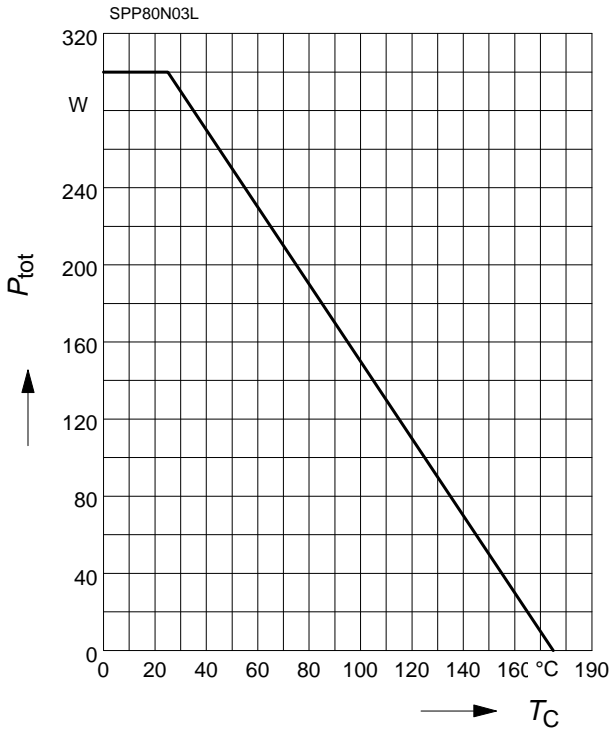
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Dynamic Characteristics</b>					
Gate to source charge $V_{DD} = 24\text{ V}, I_D = 80\text{ A}$	$Q_{gs}$	-	11	17	nC
Gate to drain charge $V_{DD} = 24\text{ V}, I_D = 80\text{ A}$	$Q_{gd}$	-	62	93	
Gate charge total $V_{DD} = 24\text{ V}, I_D = 80\text{ A}, V_{GS} = 0\text{ to }10\text{ V}$	$Q_g$	-	145	220	
Gate plateau voltage $V_{DD} = 24\text{ V}, I_D = 80\text{ A}$	$V_{(plateau)}$	-	3.68	-	V

### Reverse Diode

Inverse diode continuous forward current $T_C = 25\text{ °C}$	$I_S$	-	-	80	A
Inverse diode direct current, pulsed $T_C = 25\text{ °C}$	$I_{SM}$	-	-	320	
Inverse diode forward voltage $V_{GS} = 0\text{ V}, I_F = 160\text{ A}$	$V_{SD}$	-	1.1	1.7	V
Reverse recovery time $V_R = 15\text{ V}, I_F = I_S, di_F/dt = 100\text{ A}/\mu\text{s}$	$t_{rr}$	-	70	105	ns
Reverse recovery charge $V_R = 15\text{ V}, I_F = I_S, di_F/dt = 100\text{ A}/\mu\text{s}$	$Q_{rr}$	-	0.082	0.12	$\mu\text{C}$

### Power Dissipation

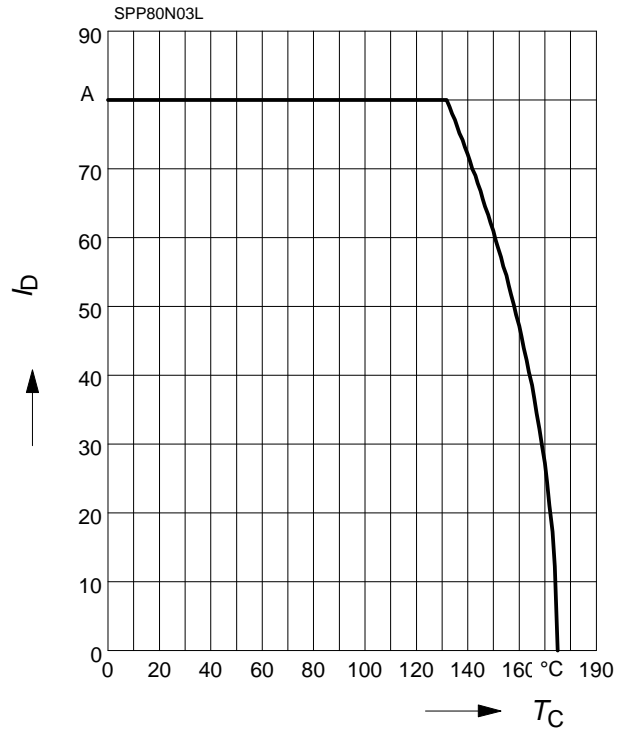
$$P_{\text{tot}} = f(T_C)$$



### Drain current

$$I_D = f(T_C)$$

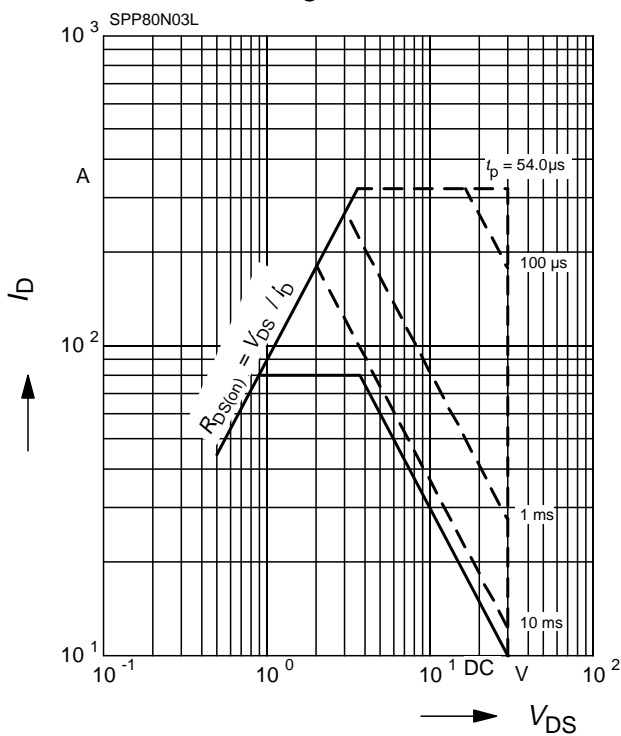
parameter:  $V_{GS} \geq 10$  V



### Safe operating area

$$I_D = f(V_{DS})$$

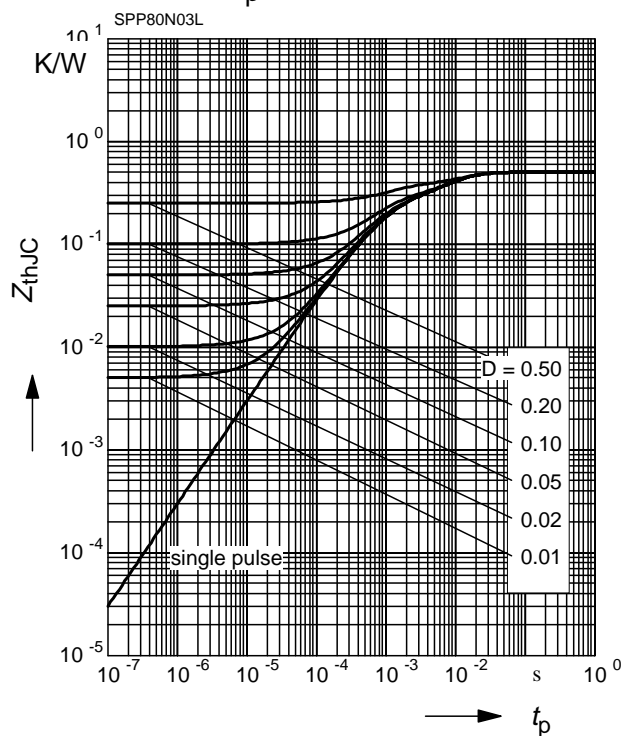
parameter:  $D = 0$ ,  $T_C = 25$  °C



### Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

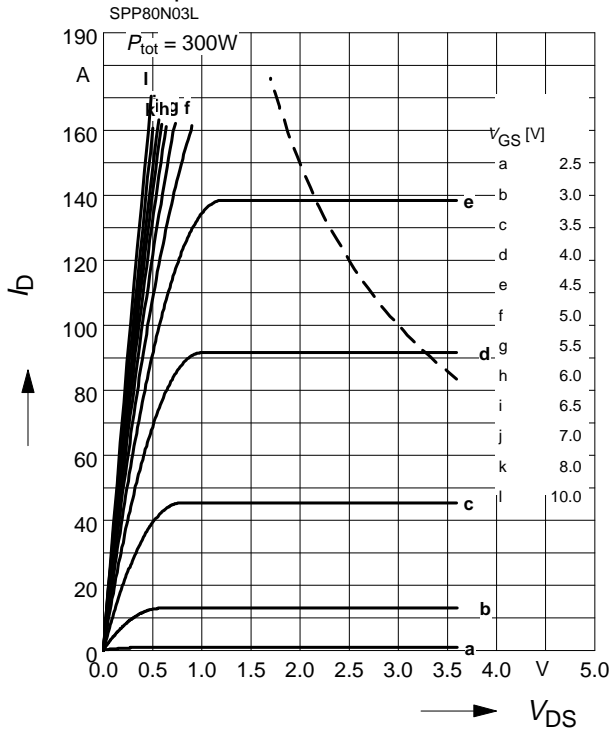
parameter:  $D = t_p / T$



### Typ. output characteristics

$$I_D = f(V_{DS})$$

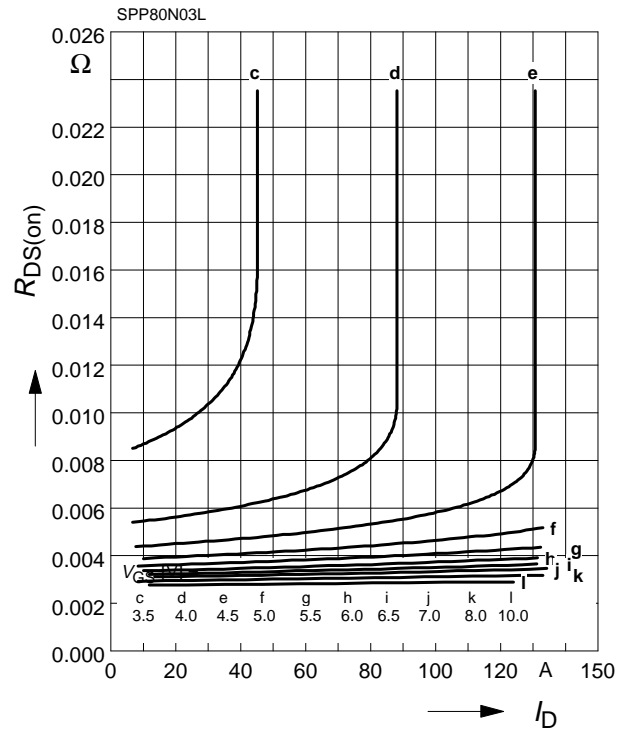
parameter:  $t_p = 80 \mu s$



### Typ. drain-source-on-resistance

$$R_{DS(on)} = f(I_D)$$

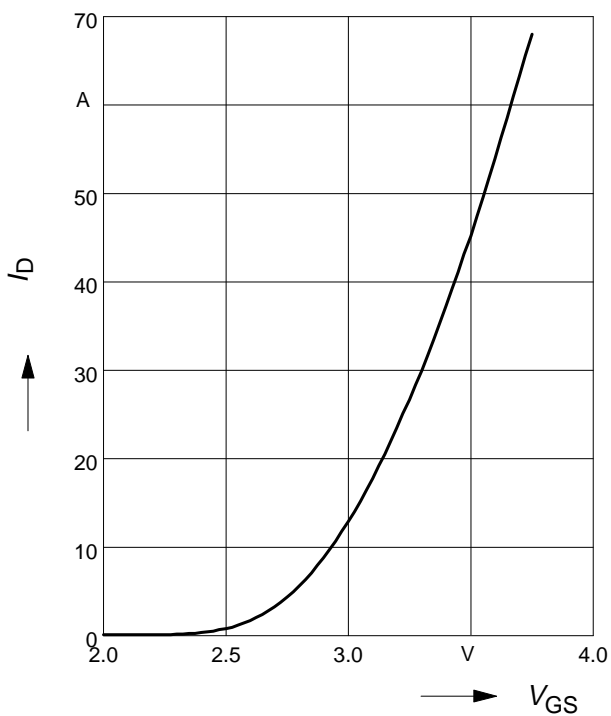
parameter:  $V_{GS}$



### Typ. transfer characteristics $I_D = f(V_{GS})$

parameter:  $t_p = 80 \mu s$

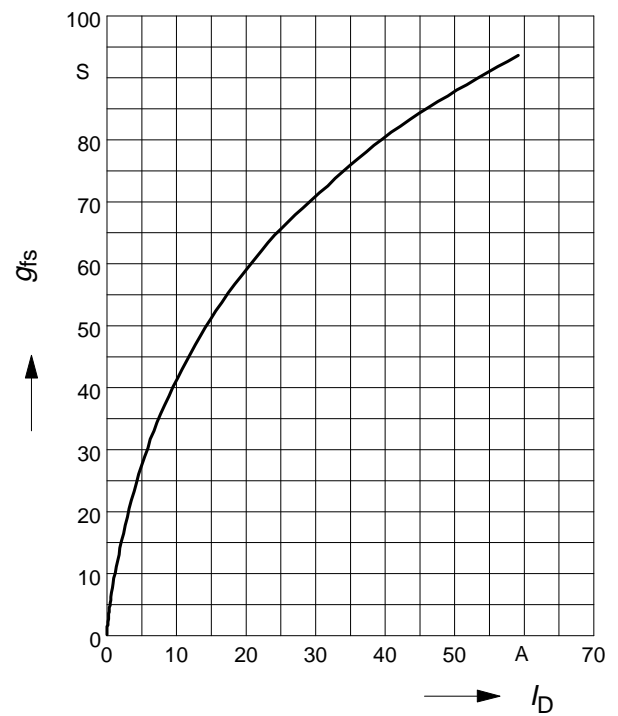
$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$



### Typ. forward transconductance

$$g_{fs} = f(I_D); T_j = 25^\circ C$$

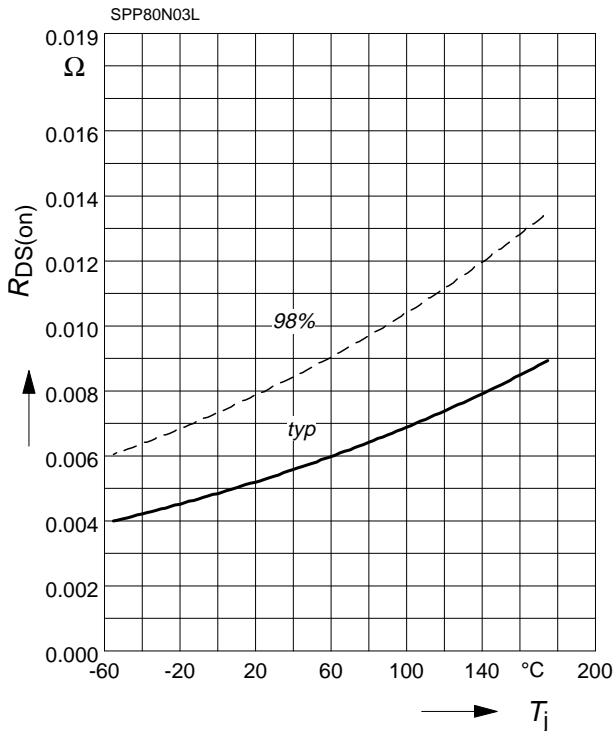
parameter:  $g_{fs}$



### Drain-source on-resistance

$$R_{DS(on)} = f(T_j)$$

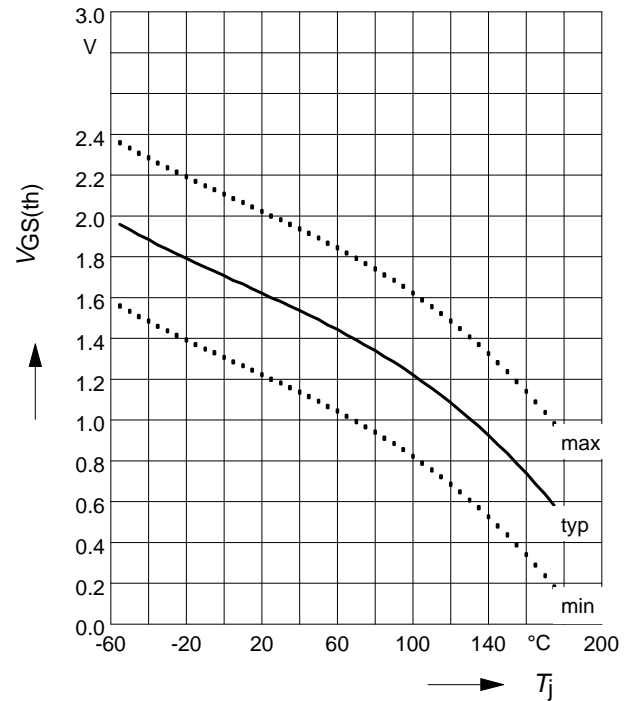
parameter :  $I_D = 80 \text{ A}$ ,  $V_{GS} = 4.5 \text{ V}$



### Gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

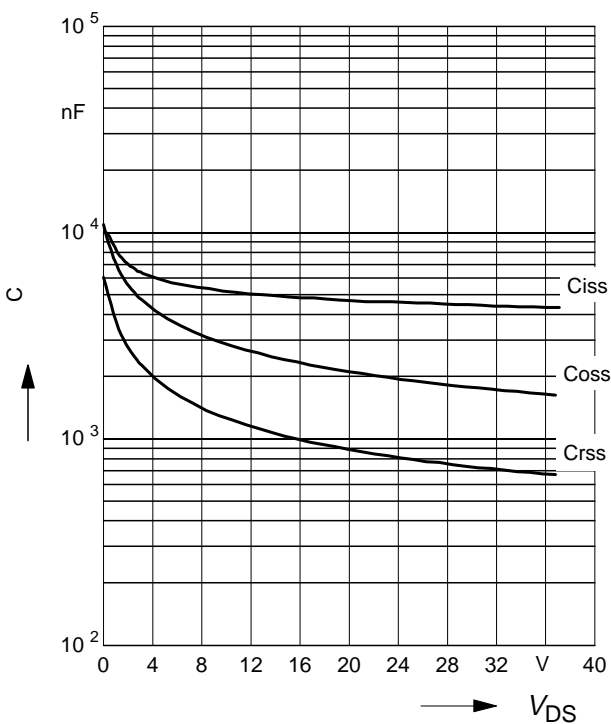
parameter :  $V_{GS} = V_{DS}$ ,  $I_D = 240 \mu\text{A}$



### Typ. capacitances

$$C = f(V_{DS})$$

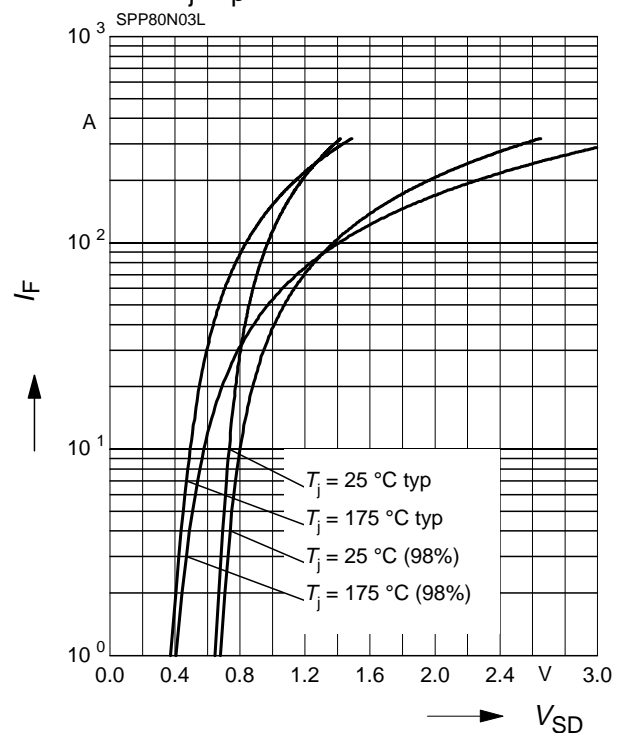
parameter:  $V_{GS} = 0 \text{ V}$ ,  $f = 1 \text{ MHz}$



### Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

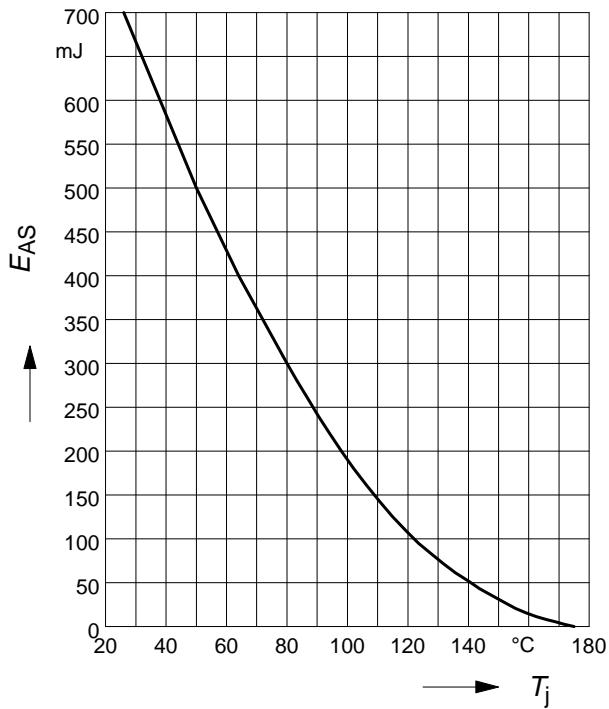
parameter:  $T_j$ ,  $t_p = 80 \mu\text{s}$



### Avalanche Energy $E_{AS} = f(T_j)$

parameter:  $I_D = 80\text{ A}$ ,  $V_{DD} = 25\text{ V}$

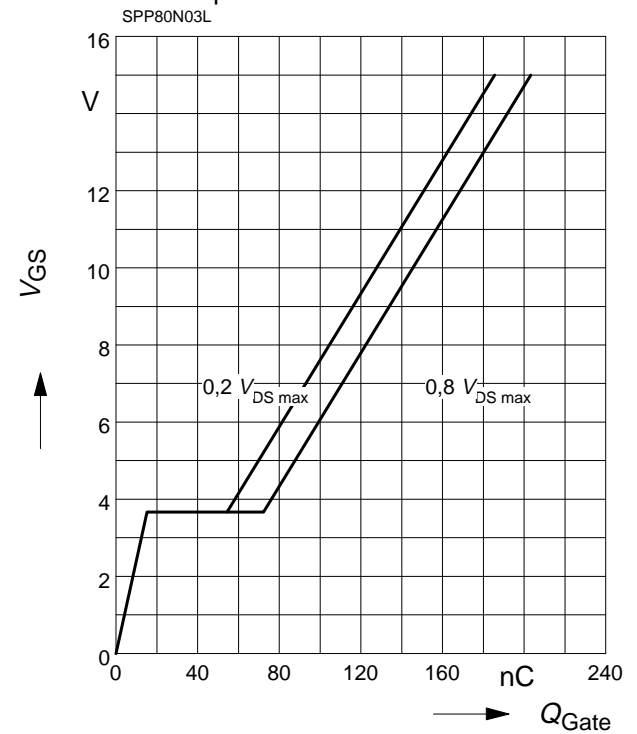
$R_{GS} = 25\ \Omega$



### Typ. gate charge

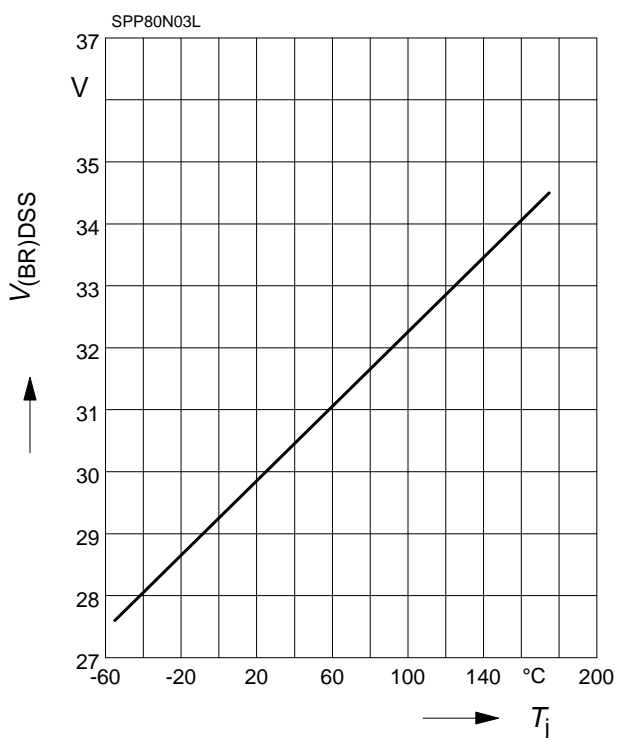
$V_{GS} = f(Q_{Gate})$

parameter:  $I_{D\text{ puls}} = 80\text{ A}$



### Drain-source breakdown voltage

$V_{(BR)DSS} = f(T_j)$



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